

# Search Notes



Application/Control No.

10/665,482

Examiner

David Dunn

Applicant(s)/Patent under Reexamination

YOSHIKAWA ET AL.

Art Unit

3616

## SEARCHED

Class	Subclass	Date	Examiner
280	729 730.1 730.2 752	9/1/2005	DD
280	743.1	2/15/06	DD
	743.2	↓	↓
UPDATED			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR